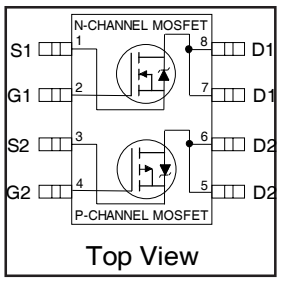
International
IOR Rectifier

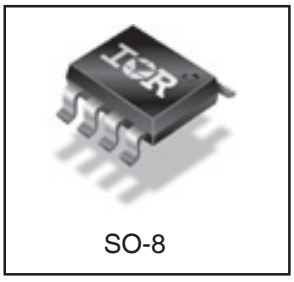
IRF7105TRPbF-1

HEXFET® Power MOSFET

	N-CH	P-CH	
V_{DS}	25	-25	V
$R_{DS(on)\ max}$ (@V_{GS} = 10V)	0.1	0.25	Ω
$Q_{g\ (typical)}$	9.4	10	nC
I_D (@T_A = 25°C)	3.5	-2.3	A



Top View


SO-8

Features		Benefits
Industry-standard pinout SO-8 Package	⇒	Multi-Vendor Compatibility
Compatible with Existing Surface Mount Techniques		Easier Manufacturing
RoHS Compliant, Halogen-Free		Environmentally Friendlier
MSL1, Industrial qualification		Increased Reliability

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRF7105PbF-1	SO-8	Tape and Reel	4000	IRF7105TRPbF-1

Absolute Maximum Ratings

	Parameter	Max.		Units
		N-Channel	P-Channel	
I_D @ T_A = 25°C	Continuous Drain Current, V_{GS} @ 10V	3.5	-2.3	A
I_D @ T_A = 70°C	Continuous Drain Current, V_{GS} @ 10V	2.8	-1.8	
I_{DM}	Pulsed Drain Current ①	14	-10	
P_D @T_C = 25°C	Power Dissipation	2.0		W
	Linear Derating Factor	0.016		W/°C
V_{GS}	Gate-to-Source Voltage	± 20		V
dv/dt	Peak Diode Recovery dv/dt ②	3.0	-3.0	V/nS
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150		°C

Thermal Resistance Ratings

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ④	—	—	62.5	°C/W

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter		Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	N-Ch	25	—	—	V	V_{GS} = 0V, I_D = 250µA
		P-Ch	-25	—	—		V_{GS} = 0V, I_D = -250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.030	—	V/°C	Reference to 25°C, I_D = 1mA
		P-Ch	—	-0.015	—		Reference to 25°C, I_D = -1mA
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	N-Ch	—	0.083	0.10	Ω	V_{GS} = 10V, I_D = 1.0A ③
			—	0.14	0.16		V_{GS} = 4.5V, I_D = 0.50A ③
		P-Ch	—	0.16	0.25		V_{GS} = -10V, I_D = -1.0A ③
			—	0.30	0.40		V_{GS} = -4.5V, I_D = -0.50A ③
$V_{GS(th)}$	Gate Threshold Voltage	N-Ch	1.0	—	3.0	V	V_{DS} = V_{GS}, I_D = 250µA
		P-Ch	-1.0	—	-3.0		V_{DS} = V_{GS}, I_D = -250µA
g_{fs}	Forward Transconductance	N-Ch	—	4.3	—	S	V_{DS} = 15V, I_D = 3.5A ③
		P-Ch	—	3.1	—		V_{DS} = -15V, I_D = -3.5A ③
I_{DSS}	Drain-to-Source Leakage Current	N-Ch	—	—	2.0	µA	V_{DS} = 20V, V_{GS} = 0V
		P-Ch	—	—	-2.0		V_{DS} = -20V, V_{GS} = 0V,
		N-Ch	—	—	25		V_{DS} = 20V, V_{GS} = 0V, T_J = 55°C
		P-Ch	—	—	-25		V_{DS} = -20V, V_{GS} = 0V, T_J = 55°C
I_{GSS}	Gate-to-Source Forward Leakage	N-P	—	—	±100		V_{GS} = ± 20V
Q_g	Total GateCharge	N-Ch	—	9.4	27	nC	N-Channel I_D = 2.3A, V_{DS} = 12.5V, V_{GS} = 10V ③ P-Channel I_D = -2.3A, V_{DS} = -12.5V, V_{GS} = -10V
		P-Ch	—	10	25		
Q_{gs}	Gate-to-Source Charge	N-Ch	—	1.7	—		
		P-Ch	—	1.9	—		
Q_{gd}	Gate-to-Drain ("Miller") Charge	N-Ch	—	3.1	—		
		P-Ch	—	2.8	—		
$t_{d(on)}$	Turn-On Delay Time	N-Ch	—	7.0	20	ns	N-Channel V_{DD} = 25V, I_D = 1.0A, R_G = 6.0Ω, R_D = 25Ω ③ P-Channel V_{DD} = -25V, I_D = -1.0A, R_G = 6.0Ω, R_D = 25Ω
		P-Ch	—	12	40		
t_r	Rise Time	N-Ch	—	9.0	20		
		P-Ch	—	13	40		
$t_{d(off)}$	Turn-Off Delay Time	N-Ch	—	45	90		
		P-Ch	—	45	90		
t_f	Fall Time	N-Ch	—	25	50		
		P-Ch	—	37	50		
L_D	Internal Drain Inductace	N-P	—	4.0	—	nH	Between lead , 6mm (0.25in.)from package and center of die contact
L_S	Internal Source Inductance	N-P	—	6.0	—		
C_{iss}	Input Capacitance	N-Ch	—	330	—	pF	N-Channel V_{GS} = 0V, V_{DS} = 15V, f = 1.0MHz P-Channel V_{GS} = 0V, V_{DS} = -15V, f = 1.0MHz
		P-Ch	—	290	—		
C_{oss}	Output Capacitance	N-Ch	—	250	—		
		P-Ch	—	210	—		
C_{rss}	Reverse Transfer Capacitance	N-Ch	—	61	—		
		P-Ch	—	67	—		

Source-Drain Ratings and Characteristics

	Parameter		Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	N-Ch	—	—	2.0	A	
		P-Ch	—	—	-2.0		
I_{SM}	Pulsed Source Current (Body Diode) ①	N-Ch	—	—	14		
		P-Ch	—	—	-9.2		
V_{SD}	Diode Forward Voltage	N-Ch	—	—	1.2	V	T_J = 25°C, I_S = 1.3A, V_{GS} = 0V ③
		P-Ch	—	—	-1.2		T_J = 25°C, I_S = -1.3A, V_{GS} = 0V ③
t_{rr}	Reverse Recovery Time	N-Ch	—	36	54	ns	N-Channel T_J = 25°C, I_F = 1.3A, di/dt = 100A/µs P-Channel ③ T_J = 25°C, I_F = -1.3A, di/dt = 100A/µs
		P-Ch	—	69	100		
Q_{rr}	Reverse Recovery Charge	N-Ch	—	41	75	nC	
		P-Ch	—	90	180		
t_{on}	Forward Turn-On Time	N-P	Intrinsic turn-on time is neglegible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

② N-Channel I_{SD} ≤ 3.5A, di/dt ≤ 90A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 150°C
P-Channel I_{SD} ≤ -2.3A, di/dt ≤ 90A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 150°C

③ Pulse width ≤ 300µs; duty cycle ≤ 2%.

④ Surface mounted on FR-4 board, t ≤ 10sec.

N-Channel

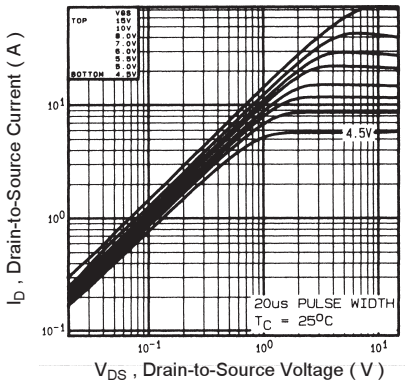


Fig 1. Typical Output Characteristics

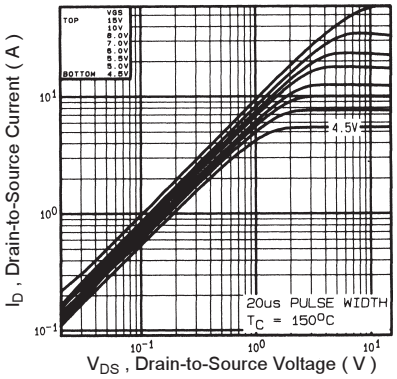


Fig 2. Typical Output Characteristics

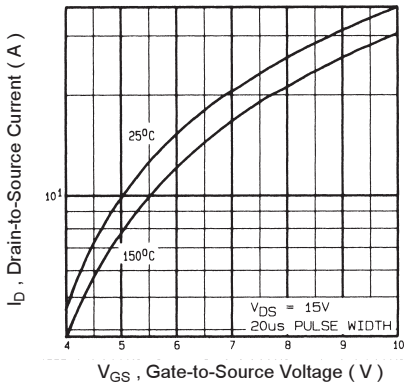


Fig 3. Typical Transfer Characteristics

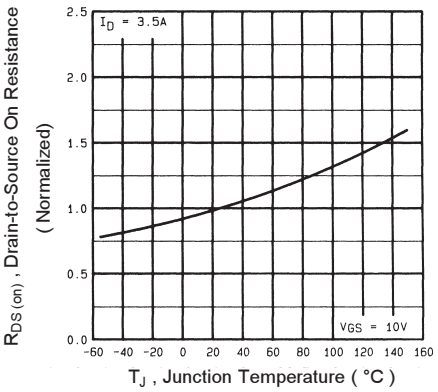


Fig 4. Normalized On-Resistance Vs. Temperature

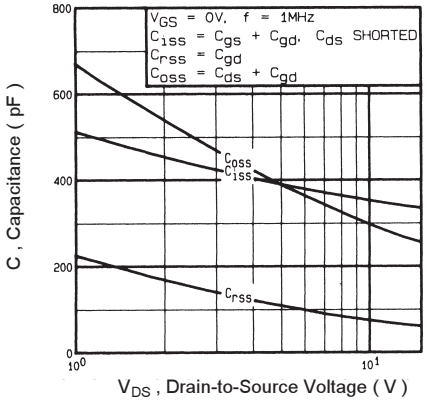


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

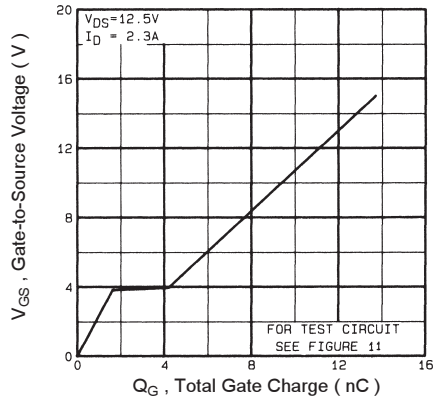


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

N-Channel

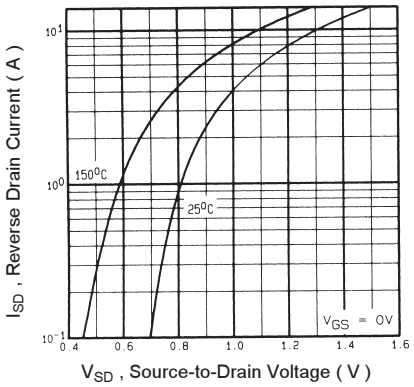


Fig 7. Typical Source-Drain Diode Forward Voltage

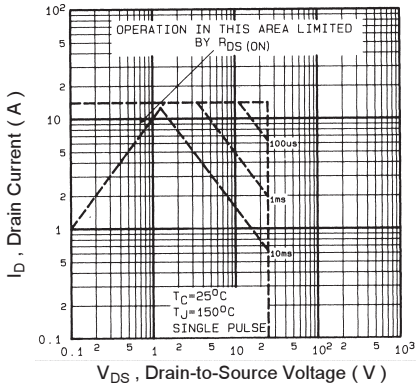


Fig 8. Maximum Safe Operating Area

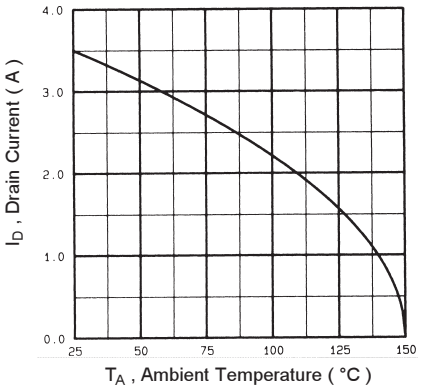


Fig 9. Maximum Drain Current Vs. Ambient Temperature

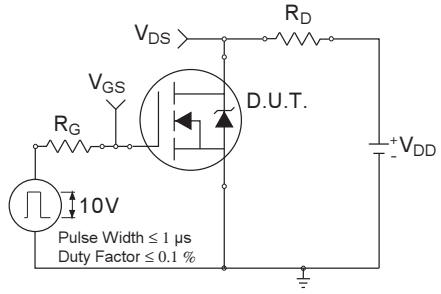


Fig 10a. Switching Time Test Circuit

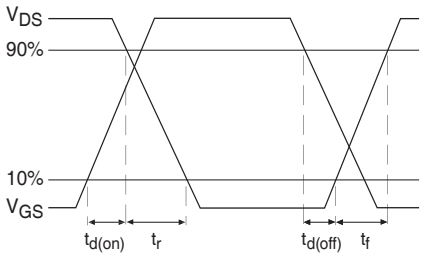


Fig 10b. Switching Time Waveforms

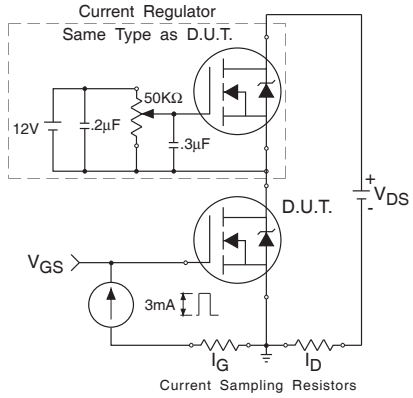


Fig 11a. Gate Charge Test Circuit

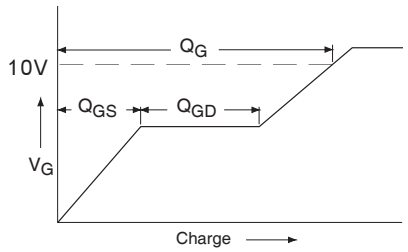


Fig 11b. Basic Gate Charge Waveform

P-Channel

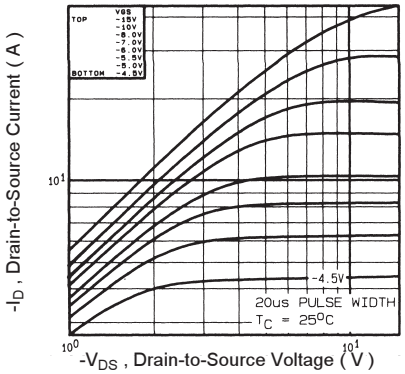


Fig 12. Typical Output Characteristics

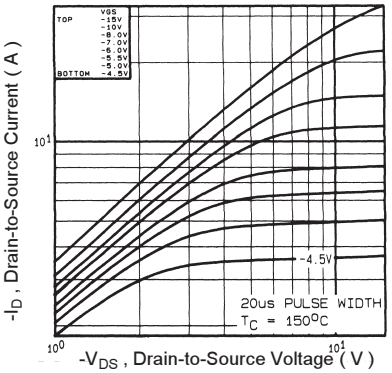


Fig 13. Typical Output Characteristics

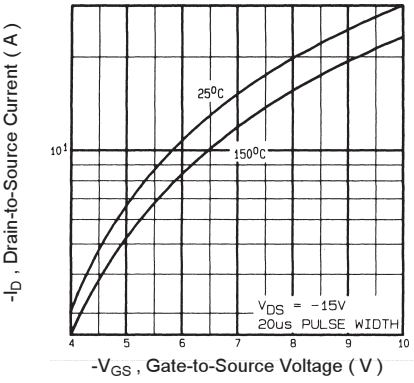


Fig 14. Typical Transfer Characteristics

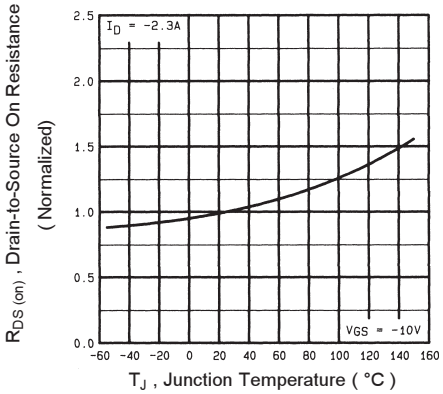


Fig 15. Normalized On-Resistance Vs. Temperature

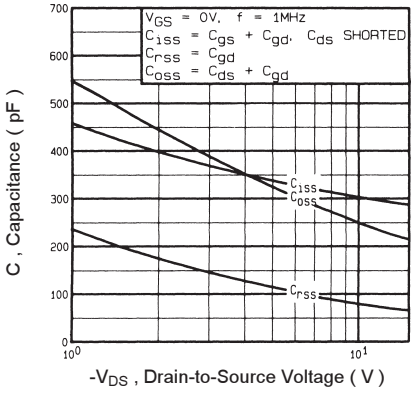


Fig 16. Typical Capacitance Vs. Drain-to-Source Voltage

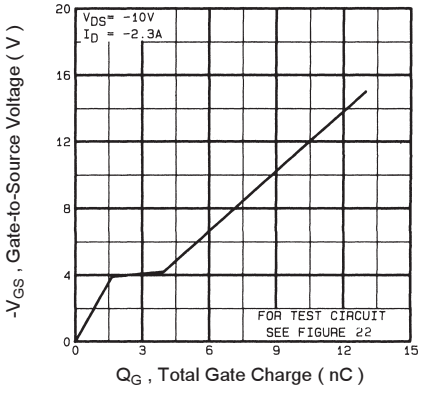


Fig 17. Typical Gate Charge Vs. Gate-to-Source Voltage

P-Channel

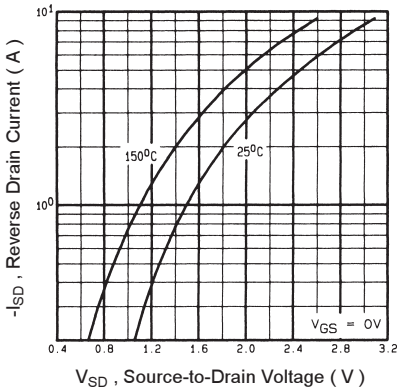


Fig 18. Typical Source-Drain Diode Forward Voltage

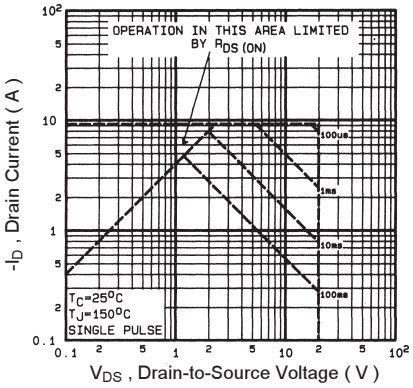


Fig 19. Maximum Safe Operating Area

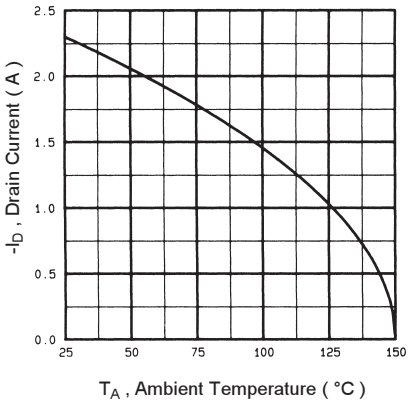


Fig 20. Maximum Drain Current Vs. Ambient Temperature

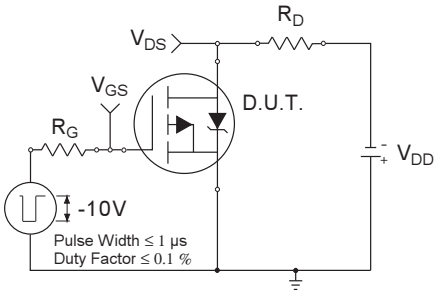


Fig 21a. Switching Time Test Circuit

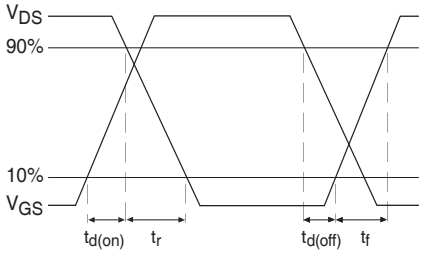


Fig 21b. Switching Time Waveforms

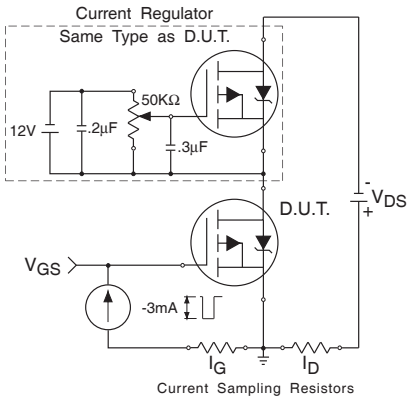


Fig 22a. Gate Charge Test Circuit

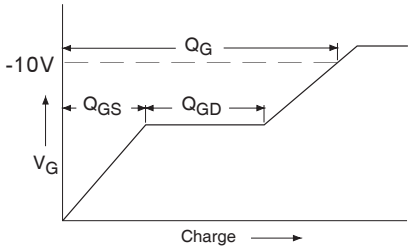


Fig 22b. Basic Gate Charge Waveform

N & P-Channel

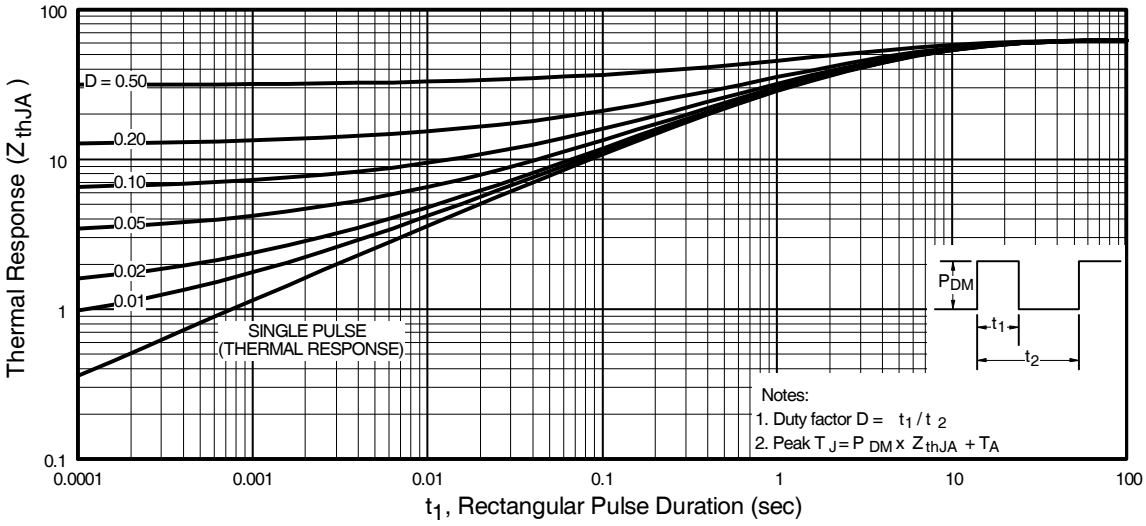
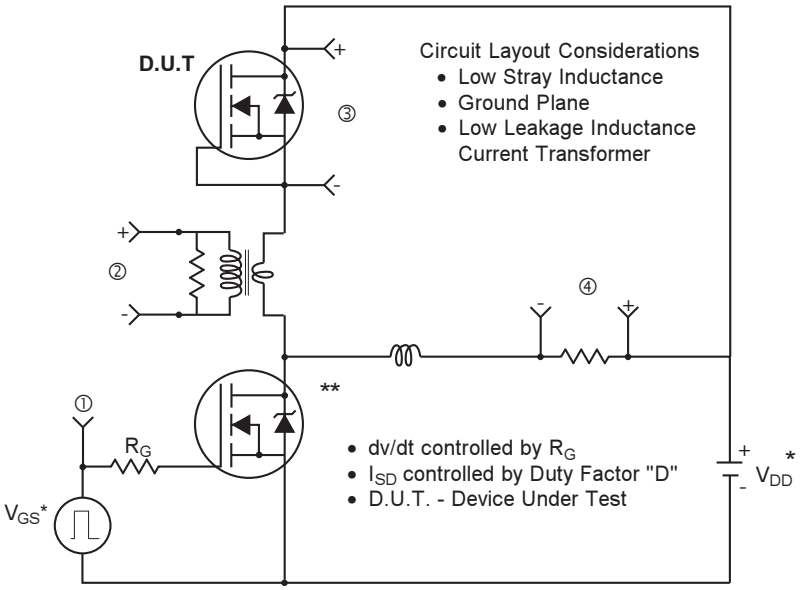
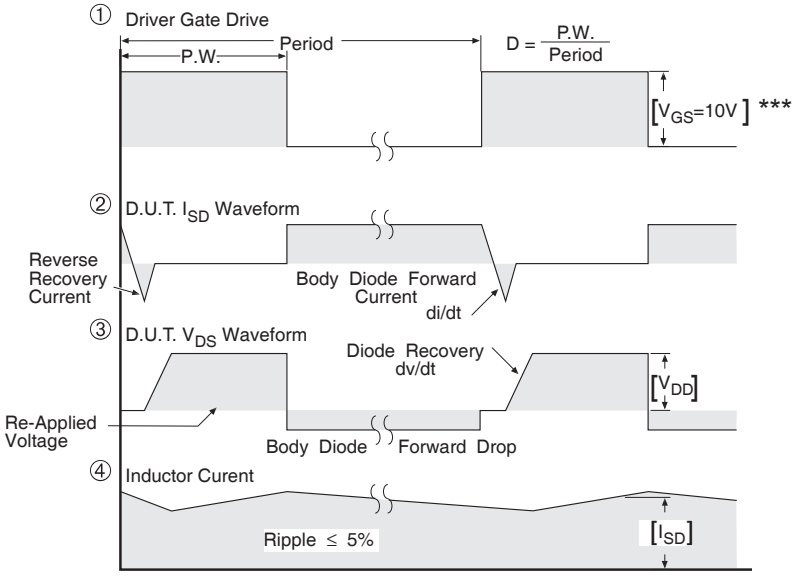


Fig 23. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity for P-Channel
** Use P-Channel Driver for P-Channel Measurements

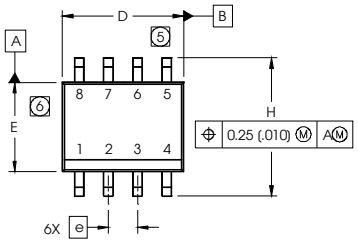


*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

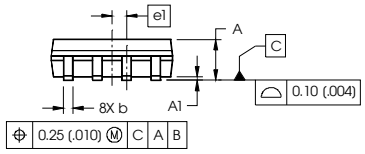
Fig 24. For N and P Channel HEXFETS

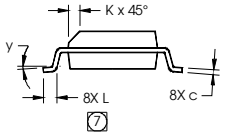
SO-8 Package Outline

Dimensions are shown in milimeters (inches)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°





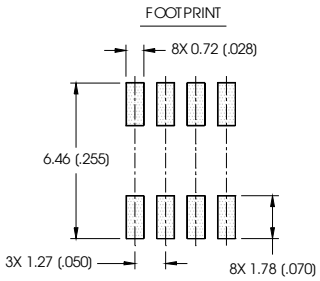
NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.

5 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).

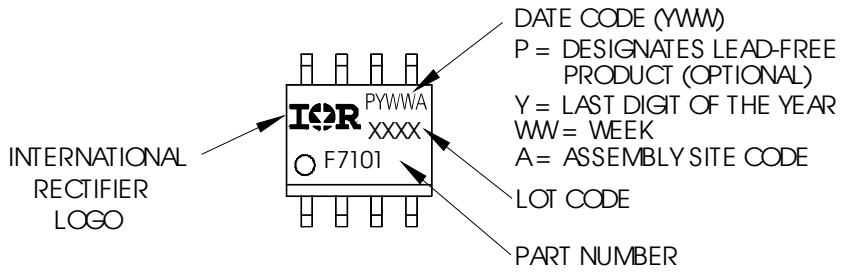
6 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).

7 DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



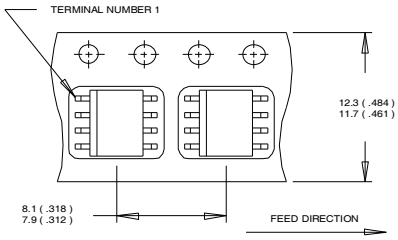
SO-8 Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

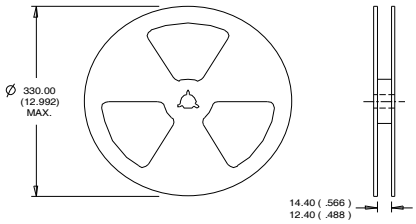


Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

SO-8 Tape and Reel (Dimensions are shown in milimeters (inches))



NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

Qualification information†

Qualification level	Industrial (per JEDEC JESD47F†† guidelines)	
Moisture Sensitivity Level	SO-8	MSL1 (per JEDEC J-STD-020D††)
RoHS compliant	Yes	

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability
†† Applicable version of JEDEC standard at the time of product release

Revision History

Date	Comments
10/16/2014	• Corrected part number from" IRF7105PbF-1" to "IRF7105TRPbF-1" -all pages • Removed the "IRF7105PbF-1" bulk part number from ordering information on page1

International
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